Attorney's Docket No.: 07977-024003 / US2975D1D1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Isamu Kobori et al.

Art Unit : Unknown

Serial No. :

New Divisional Application

Examiner: Unknown

Filed .

July 22, 2003

Title

METHOD OF MANUFACTURING A SEMICONDUCTOR METHOD OF

MANUFACTURING A THIN-FILM TRANSISTOR AND THIN-FILM

TRANSISTOR

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Under 35 USC §120, this application relies on the earlier filing dates of application serial numbers 09/016,999, filed on February 2, 1998 and 08/623,506, filed on March 28, 1996. The attached list of references were submitted to and/or cited by the Office in the prior application and, therefore, are not provided in this application.

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: July 22, 2003

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Application No. Attorney's Docket No. Substitute Form PTO-1449 U.S. Department of Commerce 07977-024003 New Divisional (Modified) Patent and Trademark Office Application Information Disclosure Statement Applicant by Applicant Isamu Kobori et al. (Use several sheets if necessary) Filing Date Group Art Unit (37 CFR §1.98(b)) July 22, 2003 Unknown **U.S. Patent Documents** Examiner Desig. Document Publication Filing Date Initial ID Number. Date Patentee Class If Appropriate Subclass 5,413,958 05/1995 AA Imahashi et al. 5,529,630 06/1996 Imahashi et al. AB AC. 5,595,923 01/1997 Zhang et al. AD 5,767,930 06/1998 Kobayashi et al. AE 5,854,494 05/1995 Yamazaki et al. 10/1999 AF 5,966,594 Adachi et al. ÅG 5,854,096 12/1998 Ohtani et al. AH 5,712,191 01/1998 Nakajima et al. ΑĮ 5,731,613 03/1998 Yamazaki et al. 5,937,282 08/1999 ΑJ Nakajima et al. AK 5,959,313 09/1999 Yamazaki et al. 6,051,453 04/2000 AL Takemura

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Examiner Signature	Date Considered
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EXAMINER: Initials citation considered. Draw line through citation if no	ot in conformance and not considered. Include copy of this form with

next communication to applicant.

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